

**Search Notes**

Application/Control No.

10/700,670

Examiner

Paul Dinh

Applicant(s)/Patent under  
Reexamination

YOSHIDA ET AL.

Art Unit

2825

**SEARCHED**

Class	Subclass	Date	Examiner
716	4-6, 11, 18	9/13/2005	PD
703	15, 19	9/13/2005	PD

**INTERFERENCE SEARCHED**

Class	Subclass	Date	Examiner
search	above	9/13/2005	PD

**SEARCH NOTES  
(INCLUDING SEARCH STRATEGY)**

	DATE	EXMR
EAST, IEEE	9/13/2005	PD